

4 8 kHz IIItra-I ow Noise 24-Bit Sigma-Delta ADC with PGA

Preliminary Technical Data

AD7192

FEATURES

RMS Noise: 14 nV @ 7.5 Hz (gain = 128) 15.5 noise free bits @ 2.4 kHz (gain = 128) Up to 22 noise free bits (gain = 1) Offset drift: 5 nV/°C Gain drift: 1 ppm/°C Specified drift over time Programmable gain (1 - 128) Output data rate: 4.7 Hz to 4.8 kHz Internal or external clock Simultaneous 50 Hz/60 Hz rejection Four general purpose digital outputs Power supply: 3 V to 5.25 V Current: 3.5 mA Temperature range: -40°C to +105°C

INTERFACE

3-wire serial SPI®, QSPI™, MICROWIRE™, and DSP compatible Schmitt trigger on SCLK

APPLICATIONS

Weigh scales Strain gauge transducers **Pressure measurement Temperature measurement** Chromatography

PLC/DCS Analog Input Modules Data Acquisition Medical and Scientific instrumentation

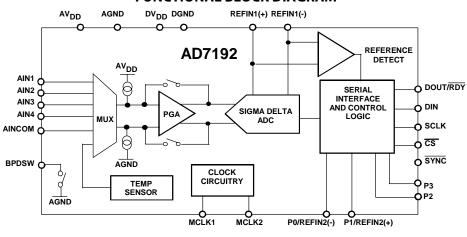
GENERAL DESCRIPTION

The AD7192 is a low noise, complete analog front end for high precision measurement applications. It contains a low noise, 24bit Σ - Δ ADC. The on-chip low noise gain stage means that signals of small amplitude can be interfaced directly to the ADC.

The device can be configured to have two differential inputs or four pseudo-differential inputs. The device can be operated with either the internal clock or an external clock. The output data rate from the part can be varied from 4.7 Hz to 4.8 kHz.

The device can be operated with a sinc³ or a sinc⁴ digital filter. At the lower output data rates, the sinc³ is useful to optimize the settling time. The benefit of the sinc⁴ at low output data rates is the superior 50 Hz/60 Hz rejection. At the higher output data rates, the sinc⁴ filter gives best noise performance. For applications that require all conversions to be settled, the AD7192 includes a zero-latency feature.

The part operates with a power supply from 3 V to 5.25 V. It consumes a current of 3.5 mA. It is housed in a 24-lead TSSOP package.



FUNCTIONAL BLOCK DIAGRAM

Figure 1.

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SPECIFICATIONS

 $AV_{DD} = 3 V to 5.25 V; DV_{DD} = 2.7 V to 5.25 V; GND = 0 V; REFIN1(+) = AV_{DD}; REFIN1(-) = GND; MCLK = 4.9152 MHz; Sinc⁴ filter MCLK = 4.9152 MLZ; Sinc⁴ filter MCLK$ selected; all specifications $T_{\mbox{\scriptsize MIN}}$ to $T_{\mbox{\scriptsize MAX}}$, unless otherwise noted.

Table 1.

Parameter ¹	AD7192B	Unit	Test Conditions/Comments
Output Data Rate	4.7 to 4800	Hz nom	Chop Disabled
	1.17 to 1200	Hz nom	Chop Enabled
No Missing Codes ²	24	Bits min	FS > 1
Resolution	See RMS Noise and Resolution Specifications		
RMS Noise and Update Rates	See RMS Noise and Resolution Specifications		
Integral Nonlinearity	±15	ppm of FSR max	
Offset Error ³	±100/Gain	μV typ	Chop Disabled
	±0.5	μV typ	Chop Enabled
Offset Error Drift vs. Temperature ⁴	±150/Gain	nV/°C typ	Gain = 1 to 16. Chop Disabled
	±10	nV/°C typ	Gain = 32 to 128. Chop Disabled
	±5	nV/°C typ	Chop Enabled
Offset Error Drift vs. Time	25	nV/1000 Hours typ	
Full-Scale Error ^{3, 5}	±10	μV typ	
Gain Drift vs. Temperature ⁴	±1	ppm/°C typ	
Gain Drift vs. Time	10	ppm/1000 Hours typ	
Power Supply Rejection	100	dB min	V _{IN} = 1 V/Gain. 120 dB typical.
NALOG INPUTS			
Differential Input Voltage Ranges	$\pm V_{\text{REF}}/gain$	V nom	$V_{REF} = REFIN(+) - REFIN(-)$, gain = 1 to 128
	± (AV _{DD} – 1V)/gain	V min/max	gain > 1
Absolute AIN Voltage Limits ²			
Unbuffered Mode	GND – 50 mV	V min	
	$AV_{DD} + 50 \text{ mV}$	V max	
Buffered Mode	GND + 200 mV	V min	
	$AV_{\text{DD}} - 200 \text{ mV}$	V max	
Analog Input Current Buffered Mode			
Input Current ²	±1	nA max	Gain = 1
	±3	nA typ	Gain > 1
Input Current Drift	±2	pA/°C typ	
Unbuffered Mode			
Input Current	±5	μA/V typ	Gain = 1. Input current varies with input voltage
	±1	μA/V typ	Gain > 1.
Input Current Drift	±50	pA/V/°C typ	
Normal Mode Rejection ²			
@ 50 Hz, 60 Hz	98	dB min	10 Hz Output Date Rate, 50 ± 1 Hz, 60 ± 1 Hz
	TBD	dB min	50 Hz Output Date Rate, REJ60 ⁶ = 1, 50 \pm 1 Hz, 60 \pm Hz
@ 50 Hz	TBD	dB min	50 Hz Output Date Rate, 50 \pm 1 Hz
@ 60 Hz	TBD	dB min	60 Hz Output Date Rate, 60 ± 1 Hz
Common-Mode Rejection			
@ DC	100	dB min	AIN = 1 V/gain
@ 50 Hz, 60 Hz ²	100	dB min	10 Hz Output Date Rate, 50 \pm 1 Hz, 60 \pm 1 Hz
@ 50 Hz, 60 Hz ²	100	dB min	50 \pm 1 Hz (50 Hz Output Date Rate), 60 \pm 1 Hz (60 Hz Output Date Rate)

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Parameter ¹	AD7192B	Unit	Test Conditions/Comments
REFIN Voltage	AV _{DD}	V nom	REFIN = REFIN(+) - REFIN(-)
Reference Voltage Range ²	1	V min	
	AV _{DD}	V max	The differential input must be limited to \pm (AV_{\mbox{\scriptsize DD}}-1V)/gain when gain >1
Absolute REFIN Voltage Limits ²	GND – 50 mV	V min	
-	$AV_{DD} + 50 \text{ mV}$	V max	
Average Reference Input Current	6	μA/V typ	
Average Reference Input Current Drift	±0.03	nA/V/°C typ	
Normal Mode Rejection ²	Same as for analog inputs		
Common-Mode Rejection	100	dB typ	
Reference Detect Levels	0.3	V min	
	0.5	V max	
TEMPERATURE SENSOR			
Accuracy	<u>+</u> 2	°C typ	Applies after user-calibration at one temperature
Sensitivity	2800	codes/°C typ	
LOW SIDE POWER SWITCH			
R _{on}	7	Ωmax	$AV_{DD} = 5 V$
	9	Ωmax	$AV_{DD} = 3 V$
Allowable Current ²	30	mA max	Continuous Current
BURNOUT CURRENTS			
AIN Current	500	nA nom	
DIGITAL OUTPUTS (P0 – P3)			
V _{он} , Output High Voltage ²	AV _{DD} – 0.6	V min	$AV_{DD} = 3V$, $I_{SOURCE} = 100 \ \mu A$
V _{oL} , Output Low Voltage ²	0.4	V max	$AV_{DD} = 3V$, $I_{SINK} = 100 \ \mu A$
Voн, Output High Voltage ²	4	Vmin	$AV_{DD} = 5V$, ISING = 100 μ A
V_{OL} , Output Low Voltage ²	0.4	V max	
Floating-State Leakage Current	±10	μA max	$AV_{DD} = 5V$, $I_{SINK} = 800 \ \mu A$
Floating-State Output Capacitance	10	1	
INTERNAL/EXTERNAL CLOCK	10	pF typ	
Internal Clock			
Frequency	4.92 <u>+</u> 4%	MHz min/max	
Duty Cycle	50:50	% typ	
External Clock/Crystal	50.50	70 typ	
Frequency	4.9152	MHz nom	
riequency	2.4576/5.12	MHz min/max	
V _{INL} , Input Low Voltage	0.8	V max	$DV_{DD} = 5 V$
Vine, input Low Voltage	0.4	V max	$DV_{DD} = 3V$
V _{INH} , Input High Voltage	2.5	Vmin	$DV_{DD} = 3 V$
vine, inpartingit voltage	3.5	Vmin	$DV_{DD} = 5V$
Input Current	±10	µA max	$MCLKIN = DV_{DD} \text{ or } GND$
LOGIC INPUTS	10	μ/(Παλ	
V _T (+)	1.4/2	V min/V max	$DV_{DD} = 5 V$
$V_{T}(-)$	0.8/1.7	V min/V max	$DV_{DD} = 5 V$
$V_{T}(+) - V_{T}(-)$	0.1/0.17	V min/V max	$DV_{DD} = 5 V$
$V_{T}(+)$	0.9/2	V min/V max	$DV_{DD} = 3 V$
V _T (-)	0.4/1.35	V min/V max	$DV_{DD} = 3V$ $DV_{DD} = 3V$
$V_{T}(+) - V_{T}(-)$	0.06/0.13	V min/V max	$DV_{DD} = 3V$ $DV_{DD} = 3V$
Input Currents	±10	μA max	$V_{IN} = DV_{DD}$ or GND
LOGIC OUTPUT (DOUT/RDY)	10		
		V min	$DV_{DD} = 3 V$, $I_{SOURCE} = 100 \mu A$
V _{он} , Output High Voltage ²	DV _{DD} – 0.6		
VoL, Output Low Voltage ²	0.4	V max	$DV_{DD} = 3 V$, $I_{SINK} = 100 \mu A$

Parameter ¹	AD7192B	Unit	Test Conditions/Comments
V _{он} , Output High Voltage ²	4	V min	$DV_{DD} = 5 V$, $I_{SOURCE} = 200 \mu A$
V _{OL} , Output Low Voltage ²	0.4	V max	$DV_{DD} = 5 V$, $I_{SINK} = 1.6 mA$
Floating-State Leakage Current	±10	μA max	
Floating-State Output Capacitance	10	pF typ	
Data Output Coding	Offset binary		
SYSTEM CALIBRATION ²			
Full-Scale Calibration Limit	$1.05 \times FS$	V max	
Zero-Scale Calibration Limit	$-1.05 \times FS$	V min	
Input Span	$0.8 \times FS$	V min	
	$2.1 \times FS$	V max	
POWER REQUIREMENTS ⁷			
Power Supply Voltage			
$AV_{DD} - AGND$	3/5.25	V min/max	
	2.7/5.25	V min/max	
Power Supply Currents			
Ald Current	TBD	mA max	Gain = 1, Buffer off
	TBD	mA max	Gain = 8, Buffer off
	TBD	mA max	Gain = 8, Buffer on
	TBD	mA max	Gain = 16 – 128, Buffer off
	TBD	mA max	Gain = 16 – 128, Buffer on
	TBD	mA max	$DV_{DD} = 3 V$
	1	mA max	$DV_{DD} = 5 V$
I _{DD} (Power-Down Mode)	1	μA max	

¹ Temperature range: -40°C to +105°C.

² Specification is not production tested but is supported by characterization data at initial product release.
 ³ Following a calibration, this error will be in the order of the noise for the programmed gain and output data rate selected.
 ⁴ Recalibration at any temperature will remove these errors.

⁵ Full-scale error applies to both positive and negative full-scale and applies at the factory calibration conditions (AV_{DD} = 5 V, gain = 1, T_A = 25°C).

⁶ REJ60 is a bit in the Mode Register. When the output data rate is set to 50 Hz, setting REJ60 to '1' places a notch at 60 Hz, allowing simultaneous 50 Hz/60 Hz rejection.
 ⁷ Digital inputs equal to DV_{DD} or GND.

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TIMING CHARACTERISTICS

 $AV_{DD} = 3 V$ to 5.25 V; $DV_{DD} = 2.7 V$ to 5.25 V; GND = 0 V, Input Logic 0 = 0 V, Input Logic $1 = DV_{DD}$, unless otherwise noted.

Table 2.

Parameter ^{1, 2}	Limit at T _{MIN} , T _{MAX} (B Version)	Unit	Conditions/Comments		
t ₃	100	ns min	SCLK high pulse width		
t4	100	ns min	SCLK low pulse width		
Read Operation					
t1	0	ns min	CS falling edge to DOUT/RDY active time		
	60	ns max	DV _{DD} = 4.75 V to 5.25 V		
	80	ns max	$DV_{DD} = 2.7 \text{ V to } 3.6 \text{ V}$		
t ₂ ³	0	ns min	SCLK active edge to data valid delay ⁴		
	60	ns max	$DV_{DD} = 4.75 V \text{ to } 5.25 V$		
	80	ns max	$DV_{DD} = 2.7 \text{ V to } 3.6 \text{ V}$		
t5 ^{5,6}	10	ns min	Bus relinquish time after CS inactive edge		
	80	ns max			
t ₆	0	ns min	SCLK inactive edge to CS inactive edge		
t7	10	ns min	SCLK inactive edge to DOUT/RDY high		
Write Operation					
t ₈	0	ns min	CS falling edge to SCLK active edge setup time ⁴		
t9	30	ns min	Data valid to SCLK edge setup time		
t ₁₀	25	ns min	Data valid to SCLK edge hold time		
t11	0	ns min	CS rising edge to SCLK edge hold time		

¹ Sample tested during initial release to ensure compliance. All input signals are specified with $t_R = t_F = 5$ ns (10% to 90% of DV_{DD}) and timed from a voltage level of 1.6 V. ² See Figure 3 and Figure 4.

³ These numbers are measured with the load circuit shown in Figure 2 and defined as the time required for the output to cross the V_{OL} or V_{OH} limits.

⁴ SCLK active edge is falling edge of SCLK.

⁵ These numbers are derived from the measured time taken by the data output to change 0.5 V when loaded with the circuit shown in Figure 2. The measured number is then extrapolated back to remove the effects of charging or discharging the 50 pF capacitor. This means that the times quoted in the timing characteristics are the true bus relinquish times of the part and, as such, are independent of external bus loading capacitances.

⁶ RDY returns high after a read of the ADC. In single conversion mode and continuous conversion mode, the same data can be read again, if required, while RDY although care should be taken to ensure that subsequent reads do not occur close to the next output update. In continuous read mode, the digital word can be read only once.

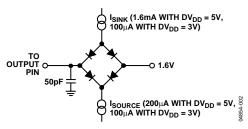
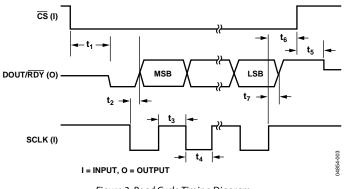
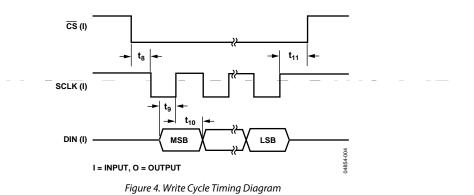


Figure 2. Load Circuit for Timing Characterization

TIMING DIAGRAMS







ABSOLUTE MAXIMUM RATINGS

 $T_A = 25^{\circ}C$, unless otherwise noted.

Table 3.

1 4010 01	
Parameter	Rating
AV _{DD} to GND	–0.3 V to +6.5 V
DV _{DD} to GND	–0.3 V to +6.5 V
Analog Input Voltage to GND	-0.3 V to AV _{DD} + 0.3 V
Reference Input Voltage to GND	-0.3 V to AV _{DD} + 0.3 V
Digital Input Voltage to GND	-0.3 V to DV _{DD} + 0.3 V
Digital Output Voltage to GND	-0.3 V to DV _{DD} + 0.3 V
AIN/Digital Input Current	10 mA
Operating Temperature Range	-40°C to +105°C
Storage Temperature Range	–65°C to +150°C
Maximum Junction Temperature	150°C
TSSOP	
θ_{JA} Thermal Impedance	97.9°C/W
θ_{JC} Thermal Impedance	14°C/W
Lead Temperature, Soldering	
Vapor Phase (60 sec)	215℃
Infrared (15 sec)	220°C

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those listed in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ESD CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although this product features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy–electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

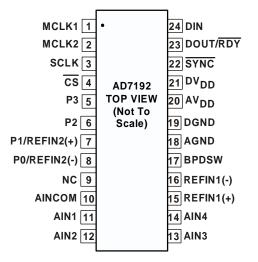


Figure 5. Pin Configuration

Table 4. Pin Function Descriptions

Pin No.	Mnemonic	Description
1	MCLK1	When the master clock for the device is provided externally by a crystal, the crystal is connected between MCLK1 and MCLK2.
2	MCLK2	Master Clock signal for the device. The AD7192 has an internal 4.92 MHz clock. This internal clock can be made available on the MCLK2 pin.
		The clock for the AD7192 can be provided externally also in the form of a crystal or external clock. A crystal can be tied across the MCLK1 and MCLK2 pins. Alternatively, the MCLK2 pin can be driven with a CMOS-compatible clock and MCLK1 left unconnected.
3	SCLK	Serial Clock Input. This serial clock input is for data transfers to and from the ADC. The SCLK has a Schmitt- triggered input, making the interface suitable for opto-isolated applications. The serial clock can be continuous with all data transmitted in a continuous train of pulses. Alternatively, it can be a noncontinuous clock with the information being transmitted to or from the ADC in smaller batches of data.
4	<u>cs</u>	Chip Select Input. This is an active low logic input used to select the ADC. \overline{CS} can be used to select the ADC in systems with more than one device on the serial bus or as a frame synchronization signal in communicating with the device. \overline{CS} can be hardwired low, allowing the ADC to operate in 3-wire mode with SCLK, DIN, and DOUT used to interface with the device.
5	P3	Digital Output Pin. This pin can function as a general purpose output bit referenced between AV _{DD} and AGND.
6	P2	Digital Output Pin. This pin can function as a general purpose output bit referenced between AV _{DD} and AGND.
7	P1/REFIN2(+)	Digital Output Pin/Positive Reference Input.
		This pin functions as a general purpose output bit referenced between AV_{DD} and AGND.
		When REFSEL = 1, this pin functions as REFIN2(+). An external reference can be applied between REFIN2(+) and REFIN2(-). REFIN2(+) can lie anywhere between AV_{DD} and $GND + 1$ V. The nominal reference voltage, (REFIN2(+) – REFIN2(-)), is AV_{DD} , but the part functions with a reference from 1 V to AV_{DD} .
8	P0/REFIN2(-)	Digital Output Pin/Negative Reference Input.
		This pin functions as a general purpose output bit referenced between AV _{DD} and AGND.
		When REFSEL = 1, this pin functions as REFIN2(-). This reference input can lie anywhere between GND and $AV_{DD} - 1 V$.
9	NC	No Connect. This pin should be tied to AGND.
10	AINCOM	Analog inputs AIN1 to AIN4 are referenced to this input when configured for pseudo-differential operation.
11	AIN1	Analog Input. It can be configured as the positive input of a fully differential input pair when used with AIN2 or as a pseudo-differential input when used with AINCOM.
12	AIN2	Analog Input. It can be configured as the negative input of a fully differential input pair when used with AIN1 or as a pseudo-differential input when used with AINCOM.
13	AIN3	Analog Input. It can be configured as the positive input of a fully differential input pair when used with

Preliminary Technical Data

Pin No.	Mnemonic	Description
		AIN4 or as a pseudo-differential input when used with AINCOM.
14	AIN4	Analog Input. It can be configured as the negative input of a fully differential input pair when used with AIN3 or as a pseudo-differential input when used with AINCOM.
15	REFIN1(+)	Positive Reference Input. An external reference can be applied between REFIN1(+) and REFIN1(-). REFIN1(+) can lie anywhere between AV_{DD} and $GND + 1 V$. The nominal reference voltage, (REFIN1(+) – REFIN1(-)), is AV_{DD} , but the part functions with a reference from 1 V to AV_{DD} .
16	REFIN1(-)	Negative Reference Input. This reference input can lie anywhere between GND and AV _{DD} – 1 V.
17	BPDSW	Low Side Power Switch to AGND.
18	AGND	Analog Ground Reference Point.
19	DGND	Digital Ground Reference Point.
20	AV _{DD}	Analog Supply Voltage, 3 V to 5.25 V. AV _{DD} is independent of DV _{DD} . Therefore DV _{DD} can be operated at 3 V with AV _{DD} at 5 V or vice versa.
21		Digital Supply Voltage, 2.7 V to 5.25 V. DV _{DD} is independent of AV _{DD} . Therefore AV _{DD} can be operated at 3 V with DV _{DD} at 5 V or vice versa.
22	SYNC	Logic Input that allows for synchronization of the digital filters and analog modulators when using a number of AD7192 devices. While SYNC is low, the nodes of the digital filter, the filter control logic and the calibration control logic are reset and the analog modulator is also held in its reset state. SYNC does not affect the digital interface but does reset RDY to a high state if it is low. SYNC has a pull- up resistor internally to DV _{DD} .
23	DOUT/RDY	Serial Data Output/Data Ready Output. DOUT/RDY serves a dual purpose. It functions as a serial data output pin to access the output shift register of the ADC. The output shift register can contain data from any of the on-chip data or control registers. In addition, DOUT/RDY operates as a data ready pin, going low to indicate the completion of a conversion. If the data is not read after the conversion, the pin will go high before the <u>next</u> update occurs. The DOUT/RDY falling edge can be used as an interrupt to a processor, indicating that valid data is available. With an external serial clock, the data can be read using the DOUT/RDY pin. With CS low, the
		data/control word information is placed on the DOUT/RDY pin on the SCLK falling edge and is valid on the SCLK rising edge.
24	DIN	Serial Data Input to the Input Shift Register on the ADC. Data in this shift register is transferred to the control registers within the ADC, the register selection bits of the communications register identifying the appropriate register.

RMS NOISE AND RESOLUTION SPECIFICATIONS

The AD7192 can be operated with chop enabled or chop disabled. With chop enabled, the settling time is two times the conversion time. The offset is continuously removed by the ADC leading to low offset and low offset drift. With chop disabled, higher output data rates can be achieved from the ADC. The settling time is three times (sinc³) or four times (sinc⁴) the selected output data rate. With chop disabled, the offset is not removed by the ADC. The offset and offset drift is comparable between chop enabled and chop disabled for gains of 32 or higher. For lower gains, however, periodic offset calibrations may be required to remove offset due to drift.

SINC⁴ FILTER

The sinc⁴ filter optimizes the 50 Hz/60 Hz rejection. At the higher output data rates, it also gives better rms noise performance compared with the sinc³ filter.

CHOP DISABLED

Table 5 shows the rms noise of the AD7192 for some of the output data rates and gain settings with chop disabled. The numbers given are for the bipolar input range with the external 5 V reference. These numbers are typical and are generated with a differential input voltage of 0 V. Table 6 shows the effective resolution while the output peak-to-peak (p-p) resolution is listed in brackets. It is important to note that the effective resolution is calculated using the rms noise, while the p-p resolution represents the resolution for which there will be no code flicker. These numbers are typical and are rounded to the nearest half-LSB.

Filter Word (Decimal)	Output Data Rate(Hz)	Settling Time (ms)	Gain of 1	Gain of 8	Gain of 16	Gain of 32	Gain of 64	Gain of 128
1023	4.7	851	350	50	30	18	13	11
640	7.5	533	410	60	36	22	16.5	14
480	10	400	460	70	40	24	19	17
96	50	80	1100	157	90	53	41	37
80	60	66.7	1400	183	100	64	46	40
32	150	26.7 – – –	2360 -	32 5 –	1 85 —	- 1-10	75	65
16	300	13.3	3000	430	240	145	105	93
5	960	4.17	4800	700	390	250	185	160
2	2400	1.67	7400	1100	640	400	300	260
1	4800	0.83	16200	2200	1200	680	465	387

Table 5. RMS Noise (nV) vs	. Gain and Output Data Rate(continuou	s conversion mode) Using a 5	V Reference - Chop Disabled

Table 6. Typical Resolution (Bits) vs. Gain and Output Data Rate(continuous conversion mode) Using a 5 V Reference - Chop Disabled

Filter Word (Decimal)	Output Data Rate(Hz)	Settling Time (ms)	Gain of 1	Gain of 8	Gain of 16	Gain of 32	Gain of 64	Gain of 128
1023	4.7	851	24 (22)	24 (22)	24 (21.5)	24 (21.5)	23.5 (21)	22.5 (20)
640	7.5	533	24 (22)	24 (21.5)	24 (21.5)	23.5 (21)	23 (20.5)	22 (19.5)
480	10	400	24 (21.5)	24 (21.5)	23.5 (21)	23.5 (21)	22.5 (20)	22 (19.5)
96	50	80	23 (20.5)	22.5 (20)	22.5 (20)	22.5 (20)	21.5 (19)	21 (18.5)
80	60	66.7	22.5 (20)	22.5 (20)	22.5 (20)	22 (19.5)	21.5 (19)	20.5 (18)
32	150	26.7	22 (19.5)	21.5 (19)	21.5 (19)	21 (18.5)	21 (18.5)	20 (17.5)
16	300	13.3	21.5 (19)	21 (18.5)	21 (18.5)	21 (18.5)	20.5 (18)	19.5 (17)
32	960	4.17	21 (18.5)	20.5 (18)	20.5 (18)	20 (17.5)	19.5 (17)	18.5 (16)
2	2400	1.67	20 (17.5)	20 (17.5)	19.5 (17)	19.5 (17)	19 (16.5)	18 (15.5)
1	4800	0.83	19 (16.5)	19 (16.5)	19 (16.5)	18.5 (16)	18 (15.5)	17.5 (15)

CHOP ENABLED

Table 7 shows the AD7192's rms noise for some of the update rates and gain settings. The numbers given are for the bipolar input range with an external 5 V reference. These numbers are typical and are generated with a differential input voltage of 0 V. Table 8 shows the effective resolution, while the output peak-to-peak (p-p) resolution is listed in brackets. It is important to note

that the effective resolution is calculated using the rms noise, while the p-p resolution is calculated based on peak-to-peak noise. The p-p resolution represents the resolution for which there will be no code flicker. These numbers are typical and are rounded to the nearest half-LSB.

Filter Word (Decimal)	Output Data Rate(Hz)	Settling Time (ms)	Gain of 1	Gain of 8	Gain of 16	Gain of 32	Gain of 64	Gain of 128
1023	1.175	1702	248	36	22	13	10	8
640	1.875	1067	290	43	26	16	12	10
480	2.5	800	326	50	29	17	14	12
96	12.5	160	778	111	64	38	29	27
80	15	133	990	130	71	46	33	29
32	37.5	53.3	1669	230	131	78	53	46
16	75	26.7	2122	304	170	103	75	66
5	240	8.33	3395	495	276	177	131	114
2	600	3.33	5233	778	453	283	213	184
1	1200	1.67	11456	1556	849	481	329	274

Table 7. RMS Noise (nV) vs. Gain and Output Data Rate(continuous conversion mode) Using a 5 V Reference - Chop Enabled

Table 8. Typical Resolution (Bits) vs. Gain and Output Data Rate(continuous conversion mode) Using a 5 V Reference - Chop Enabled

Filter Word (Decimal)	Output Data -Rate(Hz)	Settling Time (ms)	Gain of 1	Gain of 8	Gain of 16	Gain of 32	Gain of 64	Gain of 128
1023	1.175	1702	24 (22.5)	24 (22.5)	24 (22)	24 (22)	24 (21.5)	23 (20.5)
640	1.875	1067	24 (22.5)	24 (22)	24 (22)	24 (21.5)	23.5 (21)	22.5 (20)
480	2.5	800	24 (22)	24 (22)	24 (21.5)	24 (21.5)	23 (20.5)	22.5 (20)
96	12.5	160	23.5 (21)	23 (20.5)	23 (20.5)	23 (20.5)	22 (19.5)	21.5 (19)
80	15	133	23 (20.5)	23 (20.5)	23 (20.5)	22.5 (20)	22 (19.5)	21 (18.5)
32	37.5	53.3	22.5 (20)	22 (19.5)	22 (19.5)	21.5 (19)	21.5 (19)	20.5 (18)
16	75	26.7	22 (19.5)	21.5 (19)	21.5 (19)	21.5 (19)	21 (18.5)	20 (17.5)
5	240	8.33	21.5 (19)	21 (18.5)	21 (18.5)	20.5 (18)	20 (17.5)	19 (16.5)
2	600	3.33	20.5 (18)	20.5 (18)	20 (17.5)	20 (17.5)	19.5 (17)	18.5 (16)
1	1200	1.67	19.5 (17)	19.5 (17)	19.5 (17)	19 (16.5)	18.5 (16)	18 (15.5)

SINC³ FILTER

For a given update rate, the sinc³ filter has lower settling time than the sinc³ filter. At low update rates, the rms noise is comparable between the sinc³ filter and the sinc⁴ filter. So, the user can optimize the settling time without compromising the rms noise. At high update rates, the sinc⁴ filter is needed for optimum performance of the AD7192.

CHOP DISABLED

Table 9 shows the rms noise of the AD7192 for some of the update rates and gain settings with chop disabled. The

numbers given are for the bipolar input range with the external 5 V reference. These numbers are typical and are generated with a differential input voltage of 0 V. Table 10 shows the effective resolution while the output peak-to-peak (p-p) resolution is listed in brackets. It is important to note that the effective resolution is calculated using the rms noise, while the p-p resolution is calculated based on peak-to-peak noise. The p-p resolution represents the resolution for which there will be no code flicker. These numbers are typical and are rounded to the nearest half-LSB.

Filter Word (Decimal)	Output Data Rate(Hz)	Settling Time (ms)	Gain of 1	Gain of 8	Gain of 16	Gain of 32	Gain of 64	Gain of 128
1023	4.7	638	400	56	30	20	15	12
640	7.5	400	426	67	36	25	18	15
480	10	300	520	76	40	27	20	18
96	50	60	1300	176	100	61	47	40
80	60	50	1450	200	110	68	49	44
32	150	20	2450	348	198	116	81	68
16	300	10	3200	454	265	153	114	98
5	960	3.13	5600	800	455	275	199	175
2	2400	1.25	55800	7100	3600	1750	930	530
1	4800	0.625	443000	55400	27500	14000	7000	3500

Table 9. RMS Noise (nV) vs. Gain and Output Data Rate(continuous conversion mode) Using a 5 V Reference - Chop Disabled

Table 10. Typical Resolution (Bits) vs. Gain and Output Data Rate(continuous conversion mode) Using a 5 V Reference - Chop Disabled

Filter Word (Decimal)	Output Data Rate(Hz)	Settling Time (ms)	Gain of 1	Gain of 8	Gain of 16	Gain of 32	Gain of 64	Gain of 128
1023	4.7	638	24 (22)	24 (21.5)	24 (21.5)	23.5 (21)	23 (20.5)	22.5 (20)
640	7.5	400	24 (22)	24 (21.5)	24 (21.5)	23.5 (21)	23 (20.5)	22 (19.5)
480	10	300	24 (21.5)	23.5 (21)	23.5 (21)	23 (20.5)	22.5 (20)	22 (19.5)
96	50	60	22.5 (20)	22.5 (20)	22.5 (20)	22 (19.5)	21.5 (19)	20.5 (18)
80	60	50	22.5 (20)	22.5 (20)	22 (19.5)	22 (19.5)	21.5 (19)	20.5 (18)
32	150	20	21.5 (19)	21.5 (19)	21.5 (19)	21 (18.5)	20.5 (18)	20 (17.5)
16	300	10	21.5 (19)	21.5 (19)	21 (18.5)	20.5 (18)	20 (17.5)	19.5 (17)
5	960	3.13	20.5 (18)	20.5 (18)	20 (17.5)	20 (17.5)	19.5 (17)	18.5 (16)
2	2400	1.25	17 (14.5)	17 (14.5)	17 (14.5)	17 (14.5)	17 (14.5)	17 (14.5)
1	4800	0.625	14 (11.5)	14 (11.5)	14 (11.5)	14 (11.5)	14 (11.5)	14 (11.5)

CHOP ENABLED

Table 11 shows the AD7192's rms noise for some of the update rates and gain settings. The numbers given are for the bipolar input range with an external 5 V reference. These numbers are typical and are generated with a differential input voltage of 0 V. Table **12** shows the effective resolution, while the output peak-to-peak (p-p) resolution is listed in brackets. It is important to

note that the effective resolution is calculated using the rms noise, while the p-p resolution is calculated based on peak-topeak noise. The p-p resolution represents the resolution for which there will be no code flicker. These numbers are typical and are rounded to the nearest half-LSB.

Filter Word (Decimal)	Output Data Rate(Hz)	Settling Time (ms)	Gain of 1	Gain of 8	Gain of 16	Gain of 32	Gain of 64	Gain of 128
1023	1.56	1282	283	40	22	15	11	8.5
640	2.5	800	302	48	26	18	13	11
480	3.33	600	368	54	29	19	15	13
96	16.6	120	920	125	71	44	34	29
80	20	100	1026	142	78	48	35	32
32	50	40	1733	246	140	82	58	48
16	100	20	2265	321	188	109	81	70
5	320	6.25	3960	566	322	195	141	124
2	800	2.5	39460	5100	2550	1240	658	375
1	1600	1.25	313300	39200	19500	9900	4950	2475

Table 11. RMS Noise (nV) vs. Gain and Output Data Rate(continuous conversion mode) Using a 5 V Reference - Chop Enabled

Table 12. Typical Resolution (Bits) vs. Gain and Output Data Rate(continuous conversion mode) Using a 5 V Reference - Chop Enabled

Filter Word (Decimal)	Output Data -Rate(Hz)	Settling Time (ms)	Gain of 1	Gain of 8	Gain of 16	Gain of 32	Gain of 64	Gain of 128
1023	1.56	1282	24 (22.5)	24 (22)	24 (22)	24 (21.5)	23.5 (21)	23 (20.5)
640	2.5	800	24 (22.5)	24 (22)	24 (22)	24 (21.5)	23.5 (21)	22.5 (20)
480	3.33	600	24 (22)	24 (21.5)	24 (21.5)	23.5 (21)	23 (20.5)	22.5 (20)
96	16.6	120	23 (20.5)	23 (20.5)	23 (20.5)	22.5 (20)	22 (19.5)	21 (18.5)
80	20	100	23 (20.5)	23 (20.5)	22.5 (20)	22.5 (20)	22 (19.5)	21 (18.5)
32	320	40	22 (19.5)	22 (19.5)	22 (19.5)	21.5 (19)	21 (18.5)	20.5 (18)
16	100	20	22 (19.5)	22 (19.5)	21.5 (19)	21 (18.5)	20.5 (18)	20 (17.5)
5	320	6.25	21 (18.5)	21 (18.5)	20.5 (18)	20.5 (18)	20 (17.5)	19 (16.5)
2	800	2.5	17.5 (15)	17.5 (15)	17.5 (15)	17.5 (15)	17.5 (15)	17.5 (15)
1	1600	1.25	14.5 (12)	14.5 (12)	14.5 (12)	14.5 (12)	14.5 (12)	14.5 (12)

TYPICAL PERFORMANCE CHARACTERISTICS

Figure 6. Figure 9.

Figure 7.

Figure 10.

Figure 8.

Figure 11.

ON-CHIP REGISTERS

The ADC is controlled and configured via a number of on-chip registers, which are described on the following pages. In the following descriptions, *set* implies a Logic 1 state and *cleared* implies a Logic 0 state, unless otherwise noted.

COMMUNICATIONS REGISTER

(RS2, RS1, RS0 = 0, 0, 0)

The communications register is an 8-bit write-only register. All communications to the part must start with a write operation to the communications register. The data written to the communications register determines whether the next operation is a read or write operation, and to which register this operation takes place. For read or write operations, once the subsequent read or write operation to the selected register is complete, the interface returns to where it expects a write operation to the communications register. This is the default state of the interface and, on power-up or after a reset, the ADC is in this default state waiting for a write operation to the communications register. In situations where the interface sequence is lost, a write operation of at least 40 serial clock cycles with DIN high returns the ADC to this default state by resetting the entire part. Table 13 outlines the bit designations for the communications register. CR0 through CR7 indicate the bit location, CR denoting the bits are in the communications register. CR7 denotes the first bit of the data stream. The number in brackets indicates the poweron/reset default status of that bit.

CR7	CR6	CR5	CR4	CR3	CR2	CR1	CR0
WEN(0)	R/ W (0)	RS2(0)	RS1(0)	RS0(0)	CREAD(0)	0(0)	0(0)

Table 13. Communications Register Bit Designations

Bit Location	Bit Name	Description
CR7	WEN	Write Enable Bit. A 0 must be written to this bit so that the write to the communications register actually occurs. If a 1 is the first bit written, the part will not clock on to subsequent bits in the register. It will stay at this bit location until a 0 is written to this bit. Once a 0 is written to the WEN bit, the next seven bits will be loaded to the communications register.
CR6	R/W	A 0 in this bit location indicates that the next operation will be a write to a specified register. A 1 in this position indicates that the next operation will be a read from the designated register.
CR5 to CR3	RS2 to RS0	Register Address Bits. These address bits are used to select which registers of the ADC are being selected during this serial interface communication. See Table 14.
CR2	CREAD	Continuous Read of the Data Register. When this bit is set to 1 (and the data register is selected), the serial interface is configured so that the data register can be continuously read, that is, the contents of the data register are automatically placed on the DOUT pin when the SCLK pulses are applied after the RDY pin goes low to indicate that a conversion is complete. The communications register does not have to be written to for subsequent data reads. To enable continuous read, the instruction 01011100 must be written to the communications register while the RDY pin is low. While continuous read is enabled, the ADC monitors activity on the DIN line so that it can receive the instruction to disable continuous read. Additionally, a reset will occur if 40 consecutive 1s are seen on DIN. Therefore, DIN should be held low until an instruction is to be written to the device.
CR1 to CR0	0	These bits must be programmed to Logic 0 for correct operation.

Table 14. Register Selection

RS2	RS1	RS0	Register	Register Size
0	0	0	Communications Register During a Write Operation	8-bit
0	0	0	Status Register During a Read Operation	8-bit
0	0	1	Mode Register	24-bit
0	1	0	Configuration Register	24-bit
0	1	1	Data Register / Data Register + Status Information	24-bit / 32-bit
1	0	0	ID Register	8-bit
1	0	1	GPOCON Register	8-bit
1	1	0	Offset Register	24-bit
1	1	1	Full-Scale Register	24-bit

STATUS REGISTER

(RS2, RS1, RS0 = 0, 0, 0; Power-On/Reset = 0x80)

The status register is an 8-bit read-only register. To access the ADC status register, the user must write to the communications register, select the next operation to be a read, and load Bit RS2, Bit RS1, and Bit RS0 with 0. Table 15 outlines the bit designations for the status register. SR0 through SR7 indicate the bit locations, SR denoting the bits are in the status register. SR7 denotes the first bit of the data stream. The number in brackets indicates the power-on/reset default status of that bit.

SR7	SR6	SR5	SR4	SR3	SR2	SR1	SR0
RDY(1)	ERR(0)	NOREF(0)	PARITY(0)	CHD3(0)	CHD2(0)	CHD1(0)	CHD0(0)

Bit Location	Bit Name	Description
SR7	RDY	Ready Bit for ADC. <i>Cleared</i> when data is written to the ADC data register. The RDY bit is set automatically after the ADC data register has been read or a period of time before the data register is updated with a new conversion result to indicate to the user not to read the conversion data. It is also set when the part is placed in power-down mode, idle mode or when SYNC is taken low.
		The end of a conversion is also indicated by the DOUT/RDY pin. This pin can be used as an alternative to the status register for monitoring the ADC for conversion data.
SR6	ERR	ADC Error Bit. This bit is written to at the same time as the RDY bit. <i>Set</i> to indicate that the result written to the ADC data register has been clamped to all 0s or all 1s. Error sources include overrange, underrange, or the absence of a reference voltage. <i>Cleared</i> by a write operation to start a conversion.
SR5	NOREF	No External Reference Bit. <i>Set</i> to indicate that the selected reference (REFIN1 or REFIN2) is at a voltage that is below a specified threshold. When set, conversion results are clamped to all ones. <i>Cleared</i> to indicate that a valid reference is applied to the selected reference pins. The NOXREF bit is enabled by setting the REF_DET bit in the configuration register to 1. The ERR bit is also set if the voltage applied to the selected reference input is invalid.
SR4	PARITY	Parity Check of Data Register.
		If the ENPAR bit is set, the PARITY bit is set if there is an odd number of 1s in the data register. It is cleared if there is an even number of 1s in the data register. The DAT_STA bit should be set when the parity check is used. When the DAT_STA bit is set, the contents of the status register are transmitted along with the data for each data register read.
SR3 to SR0	CHD3 to CHD0	These bits indicate which channel corresponds to the data register contents. They do not indicate which channel is presently being converted but indicate which channel was selected when the conversion contained in the data register was being generated.

Table 15. Status Register Bit Designations Did to action

MODE REGISTER

(RS2, RS1, RS0 = 0, 0, 1; Power-On/Reset = 0x080060)

The mode register is a 24-bit register from which data can be read or to which data can be written. This register is used to select the operating mode, the update rate, and the clock source. Table 16 outlines the bit designations for the mode register. MR0 through MR23 indicate the bit locations, MR denoting the bits are in the mode register. MR23 denotes the first bit of the data stream. The number in brackets indicates the power-on/reset default status of that bit. Any write to the mode register resets the modulator and filter and sets the RDY bit.

MR23	MR22	MR21	MR20	MR19	MR18	MR17	MR16
MD2(0)	MD1(0)	MD0(0)	DAT_STA(0)	CLK1(1)	CLK0(0)	0	0
MR15	MR14	MR13	MR12	MR11	MR10	MR9	MR8
SINC3(0)	0	ENPAR(0)	0	SINGLE(0)	REJ60(0)	FS9(0)	FS8(0)
MR7	MR6	MR5	MR4	MR3	MR2	MR1	MRO
FS7(0)	FS6(1)	FS5(1)	FS4(0)	FS3(0)	FS2(0)	FS1(0)	FS0(0)

Table 16. Mode Register Bit Designations

Bit Location	Bit Name	Description
MR23 to MR21	MD2 to MD0	Mode Select Bits. These bits select the operational mode of the AD7192 (see Table 17).
MR20	DAT_STA	Transmit status register contents after each data register read.
		When DAT_STA is set, the contents of the status register are transmitted along with each data register

Preliminary Technical Data

Bit Location	Bit Name	Descript	ion					
				useful when several channels are selected as the status register identifies the				
				data register value corresponds.				
MR19 to MR18	CLK1 to CLK0			select the clock source for the AD7192. Either the on-chip 4.92 MHz clock can				
				l clock can be used. The ability to use an external clock allows several AD7192 nized. Also, 50 Hz/60 Hz rejection is improved when an accurate external clock				
		drives the		mized. Also, 50 Hz/00 Hz rejection is improved when an accurate external clock				
		CLK1	CLK0	ADC Clock Source				
		0	0	External crystal used. The external crystal is connected from MCLK1 to MCLK2.				
		0	1	External clock used. The external clock is applied to the MCLK2 pin.				
		1	0	Internal 4.92 MHz clock. Pin MCLK2 is tri-stated.				
		1	1	Internal 4.92 MHz clock. The internal clock is available on MCLK2.				
MR17 to MR16	0	These bit	s must be pro	ogrammed with a Logic 0 for correct operation.				
MR15	SINC3		er Select pin.					
WIIIIS	Sirves							
			When this bit is cleared, the sinc ⁴ filter is used (default value). When this bit is set, a sinc ³ filter is used.					
			-	c ³ filter compared to the sinc ⁴ filter is its lower settling time when chop is				
				butput data rate f_{ADC} , the sinc ³ filter has a settling time of $f_{ADC}/3$ while the sinc ⁴				
				ne of f _{ADC} /4. The sinc ⁴ filter, due to its deeper notches, gives better 50 Hz/60 Hz				
		rejection.						
				ooth filters give similar rms noise and similar no missing codes for a given update				
				e rates (FS values less than 5), the sinc ⁴ filter gives better performance than the				
MD14	0			se and no missing codes.				
MR14	0			rammed with a Logic 0 for correct operation.				
MR13	ENPAR	Enable Parity bit.						
				arity checking on the data register is enabled. The DAT_STA bit should be set < is used. When the DAT_STA bit is set, the contents of the status register are				
				h the data for each data register read.				
MR12	0		-	rammed with a Logic 0 for correct operation.				
MR11	SINGLE			on Enable Bit.				
				e AD7192 allows the complete settling time to perform each conversion. So, the				
				zero-latency ADC.				
MR10	REJ60	Enables a	notch at 60	Hz when the output data rate is equal to 50 Hz.				
		When RE.	J60 is set, a fi	lter notch is placed at 60 Hz when the output data rate selected is 50 Hz. This				
		allows sin	nultaneous 5	50 Hz/60 Hz rejection.				
MR9 to MR0	FS9 to FS0	Filter Out	put Data Rat	e Select Bits.				
				ogrammed into these bits determine the filter cut-off frequency, the position of				
				ilter and the output data rate for the part. In association with the gain selection, output noise (and hence the effective resolution) of the device. When chop is				
				bus conversion mode is selected, the first notch of the filter occurs at a frequency				
			ed by the rel					
			•	ency = (fmod/64)/FS				
		where FS	is the decim	al equivalent of the code in bits FS0 to FS9 and is in the range 1 to 1023 and				
		fmod is th	ne modulato	r frequency which is equal to MCLK/16. With the nominal MCLK of 4.92 MHz, this				
				frequency range from 4.69 Hz to 4.8 kHz.				
				tch frequency, as well as the selected gain, impacts resolution. Tables 5 through				
				ne filter notch frequency and gain on the effective resolution of the AD7192. The				
				ffective conversion time) for the device is equal to the frequency selected for the . For example, if the first notch of the filter is selected at 50 Hz then a new word				
				rate or every 20 ms. If the first notch is at 1.2 kHz, a new word is available every				
				ime of the filter to a full-scale step input change is worst case (N + 1)/(output				
				3 when the sinc ³ filter is selected and $N = 4$ when the sinc ⁴ filter is selected. For				
				t filter notch at 50 Hz, the settling time of the filter to a full-scale step input				
				when N = 4. This settling time can be reduced to N/(output data rate) by pinput change to a reset of the digital filter. In other words, if the step input				
				YNC input low, the settling time will be N/(output data rate) from when SYNC				
				ge of channel takes place, the settling time is N/(output data rate) regardless of				
				e part issues an internal reset command when requested to change channels.				
		The –3 dE	B frequency i	s determined by the programmed first notch frequency according to the				

Bit Location	Bit Name	Description
		relationship:
		filter -3 dB frequency = 0.23 x filter first notch frequency.
		When chop is enabled, the output data rate equals
		Output data rate = (fmod/64)/(NxFS)
		where FS is the decimal equivalent of the code in bits FS0 to FS9 and is in the range 1 to 1023 and fmod is the modulator frequency which is equal to MCLK/16. With the nominal MCLK of 4.92 MHz, this results in an output data rate from 4.69/N Hz to 4.8/N kHz where N is the order of the sinc filter. The first notch in the frequency response is placed at output data rate/2. The settling time is equal to 2 x conversion time.

Table 17. Operating Modes

MD2	MD1	MD0	Mode
0	0	0	Continuous Conversion Mode (Default).
			In continuous conversion mode, the ADC continuously performs conversions and places the result in the data register. RDY goes low when a conversion is complete. The user can read these conversions by setting the CREAD bit in the communications register to '1' which enables continuous read. When continuous read is enabled, the conversions are automatically placed on the DOUT line when SCLK pulses are applied. Alternatively, the user can instruct the ADC to output each conversion by writing to the communications register.
			After power-on, a reset or a re-configuration of the ADC, the complete settling time of the filter is required to generate the first valid conversion. Subsequent conversions are available at the selected output data rate which is dependent on filter choice.
0	0	1	Single Conversion Mode.
			When single conversion mode is selected, the ADC powers up and performs a single conversion on the selected channel. The oscillator requires 1 ms to power up and settle. The ADC then performs the conversion which requires the complete settling time of the filter. The conversion result is placed in the data register, RDY goes low, and the ADC returns to power-down mode. The conversion remains in the data register and RDY remains active (low) until the data is read or another conversion is performed.
0	1	0	Idle Mode.
			In idle mode, the ADC filter and modulator are held in a reset state although the modulator clocks are still provided.
0	1	1	Power-Down Mode.
			In power-down mode, all the AD7192 circuitry, except the power switch, is powered down. The power switch remains active as the user may need to power up the sensor prior to powering up the AD7192 for settling reasons. The external crystal, if present, is left active.
1	0	0	Internal Zero-Scale Calibration.
			An internal short is automatically connected to the input. $\overline{\text{RDY}}$ goes high when the calibration is initiated and returns low when the calibration is complete. The ADC is placed in idle mode following a calibration. The measured offset coefficient is placed in the offset register of the selected channel.
1	0	1	Internal Full-Scale Calibration.
			A full-scale input voltage is automatically connected to the input for this calibration.
			RDY goes high when the calibration is initiated and returns low when the calibration is complete. The ADC is placed in idle mode following a calibration. The measured full-scale coefficient is placed in the full-scale register of the selected channel.
			A full-scale calibration is required each time the gain of a channel is changed to minimize the full-scale error.
1	1	0	System Zero-Scale Calibration.
			User should connect the system zero-scale input to the channel input pins as selected by the CH7 to CH0 bits. RDY goes high when the calibration is initiated and returns low when the calibration is complete. The ADC is placed in idle mode following a calibration. The measured offset coefficient is placed in the offset register of the selected channel.
1	1	1	System Full-Scale Calibration.
			User should connect the system full-scale input to the channel input pins as selected by the CH7–CH0 bits.
			RDY goes high when the calibration is initiated and returns low when the calibration is complete. The ADC is placed
			in idle mode following a calibration. The measured full-scale coefficient is placed in the full-scale register of the selected channel.
			A full-scale calibration is required each time the gain of a channel is changed.

CONFIGURATION REGISTER

(RS2, RS1, RS0 = 0, 1, 0; Power-On/Reset = 0x000117)

The configuration register is a 24-bit register from which data can be read or to which data can be written. This register is used to configure the ADC for unipolar or bipolar mode, enable or disable the buffer, enable or disable the burnout currents, select the gain, and select the analog input channel.

Table 18 outlines the bit designations for the filter register. CON0 through CON23 indicate the bit locations. CON denotes that the bits are in the configuration register. CON23 denotes the first bit of the data stream. The number in brackets indicates the power-on/reset default status of that bit.

CON23	CON22	CON21	CON20	CON19	CON18	CON17	CON16
CHOP(0)	0(0)	0(0)	REFSEL(0)	0(0)	0(0)	0(0)	(0)
CON15	CON14	CON13	CON12	CON11	CON10	CON9	CON8
CH7(0)	CH6(0)	CH5(0)	CH4(0)	CH3(0)	CH2(0)	CH1(0)	CH0(1)
CON7	CON6	CON5	CON4	CON3	CON2	CON1	CON0
BURN(0)	REFDET(0)	0(0)	BUF(1)	U/B (0)	GN2(1)	GN1(1)	GN0(1)

Table 18. Configuration Register Bit Designations

Bit							
Location	Bit Name	Description					
CON23	CHOP	Chop Enable Bit.					
		When CHOP is cleared, chop is disabled.					
		When CHOP is set	, chop is disabled.				
		When chop is enabled, the offset and offset drift is continuously removed by the ADC. However, increases the conversion time and settling time of the ADC. For example, when FS = 96 decimal a sinc ⁴ filter is selected, the conversion time with chop enabled equals 80 ms and the settling time 160 ms. With chop disabled, higher conversion rates are allowed. For an SF word of 96 decimal a sinc ⁴ filter selected, the conversion time is 20 ms and the settling time is 80 ms. However, at low of					
			ns may be required to remove the offset and offset drift.				
CON22, CON21	0	These bits must be	e programmed with a Logic 0 for correct operation.				
CON20	REFSEL	Reference Select E	Bits. The reference source for the ADC is selected using these bits.				
		REFSEL	Reference Voltage				
		0	External reference applied between REFIN1(+) and REFIN1(–)				
		1	External reference applied between the P1 and P0 pins.				
CON19 to CON16	0	These bits must be programmed with a Logic 0 for correct operation.					
CON15 to	CH7 to CH0	Channel Select Bit	S.				
can be selected and the AD7			d to select which channels are enabled on the AD7192. See Table 19. Several channels nd the AD7192 will automatically sequence between them. The conversion on each re the complete settling time.				
CON7	BURN	When this bit is set to 1 by the user, the 500 nA current sources in the signal path are enabled. When BURN = 0, the burnout currents are disabled. The burnout currents can be enabled only when the buffer is active.					
CON6	REFDET	Enables the Refere	ence Detect Function.				
		When <i>set</i> , the NOXREF bit in the status register indicates when the external reference being used by the ADC is open circuit or less than 0.5 V.					
CON5	0	This bit must be p	rogrammed with a Logic 0 for correct operation.				
CON4							
		above AV _{DD} . When	sabled, the voltage on the analog input pins can be from 50 mV below GND to 50 mV a the buffer is enabled, it requires some headroom so the voltage on any input pin must mV within the power supply rails.				

Bit Location	Bit Name	Descripti	on					
CON3		Polarity Select bit.						
CONS	0/0	When this bit is set, unipolar operation is selected.						
				• •	eration is selected.			
				d, bipolai op	eration is selected.			
CON2 to CON0	G2 to G0	Gain Seleo	t Bits.					
		Written by the user to select the ADC input range as follows:						
		G2	G1	G0	Gain	ADC Input Range (5 V Reference)		
		0	0	0	1	5 V		
		0	0	1	Reserved			
		0	1	0	Reserved			
		0	1	1	8	625 mV		
		1	0	0	16	312.5 mV		
		1	0	1	32	156.2 mV		
		1	1	0	64	78.125 mV		
		1	1	1	128	39.06 mV		

Table 19. Channel Selection

CH7	CH6	CH5	CH4	CH3	CH2	CH1	CH0	Channel	CHD[3:0]	Calibration Pair
Х	Х	Х	Х	Х	Х	Х	1	AIN1 – AIN2	0000	0
Х	Х	Х	Х	Х	Х	1	Х	AIN3 – AIN4	0001	1
Х	Х	Х	Х	Х	1	Х	Х	Temp Sensor	0010	None
Х	Х	Х	Х	1	Х	Х	Х	AIN2 – AIN2	0011	0
Х	Х	Х	1	Х	Х	Х	Х	AIN1 – AINCOM	0100	0
Х	Х	1	Х	Х	Х	Х	Х	AIN2 – AINCOM	0101	1
Х	1	Χ	Χ	X	<u>X</u>	Х	Х		_0110	2
1	Х	Х	Х	Х	Х	Х	Х	AIN4 – AINCOM	0111	3

DATA REGISTER

(RS2, RS1, RS0 = 0, 1, 1; Power-On/Reset = 0x000000)

The conversion result from the ADC is stored in this data register. This is a read-only register. On completion of a read operation from this register, the $\overline{\text{RDY}}$ bit/pin is set. The AD7192 can be configured for 24-bit transfers or 32-bit transfers. When 24-bit transfers are selected, the 24-bit data conversion is transmitted. When 32-bit transfers are selected, the 24-bit conversion is followed by the contents of the status register. When several channels are enabled, the ADC will automatically step between channels. So, 32-bit transmissions are required so that the user can identify the channel from which the conversions originated.

GPOCON REGISTER

(RS2, RS1, RS0 = 1, 0, 1; Power-On/Reset = 0x00)

The GPOCON register is an 8-bit register from which data can be read or to which data can be written. This register is used to enable the general purpose digital outputs.

Table 20 outlines the bit designations for the GPOCON register. GP0 through GP7 indicate the bit locations. GP denotes that the bits are in the GPOCON register. GP7 denotes the first bit of the data stream. The number in brackets indicates the power-on/reset default status of that bit.

GP7	GP6	GP5	GP4	GP3	GP2	GP1	GP0
0(0)	BPDSW(0)	GP32EN(0)	GP10EN(0)	P3DAT(0)	P2DAT(0)	P1DAT(0)	PODAT(0)

Table 20. Register Bit Designations

Bit Location	Bit Name	Description
GP7	0	This bit must be programmed with a Logic 0 for correct operation.
GP 6	BPDSW	Power Switch Control Bit. <i>Set</i> by user to close the power switch BPDSW to AGND. The power switch can sink up to 30 mA. <i>Cleared</i> by user to open the power switch. When the ADC is placed in power-down mode, the power switch remains active.
GP5	GP32EN	Digital Outputs P3 and P2 Enable.
		When GP32EN is set, the digital outputs P3 and P2 are active. When GP32EN is cleared, the pins P3 and P2 are tri-stated and bits P3DAT and P2DAT are ignored.
GP4	GP10EN	Digital Outputs P1 and P0 Enable.
		When GP10EN is set, the digital outputs P1 and P0 are active. When GP10EN is cleared, the P1 and P0 outputs are tri-stated and bits P1DAT and P0DAT are ignored. The pins P1 and P0 can be used as a reference input REFIN2 when bit REFSEL in the configuration register is set to 1.
GP3	P3DAT	Digital Output P3. When GP32EN is <i>set</i> , the P3DAT bit sets the value of the general purpose output pin P3. When P3DAT is high, the output P3 is high. When P3DAT is low, the output P3 is low.
GP2	P2DAT	Digital Output P2. When GP32EN is <i>set</i> , the P2DAT bit sets the value of the general purpose output pin P2. When P2DAT is high, the output P2 is high. When P2DAT is low, the output P2 is low.
GP1	P1DAT	Digital Output P1. When GP10EN is <i>set</i> , the P1DAT bit sets the value of the general purpose output pin P1. When P1DAT is high, the output P1 is high. When P1DAT is low, the output P1 is low.
GP0	PODAT	Digital Output P0. When GP10EN is <i>set</i> , the P0DAT bit sets the value of the general purpose output pin P0. When P0DAT is high, the output P0 is high. When P0DAT is low, the output P0 is low.

OFFSET REGISTER

(RS2, RS1, RS0 = 1, 1, 0; Power-On/Reset = 0x800000)

The offset register holds the offset calibration coefficient for the ADC. The power-on reset value of the offset register is 0x800000. The AD7192 has four offset registers so each channel has a dedicated offset register. Each of these registers is a 24-bit read/write register. This register is used in conjunction with its associated full-scale register to form a register pair. The power-on reset value is automatically overwritten if an internal or system zero-scale calibration is initiated by the user. The AD7192 must be placed in power-down mode or idle mode when writing to the offset register.

FULL-SCALE REGISTER

(RS2, RS1, RS0 = 1, 1, 1; Power-On/Reset = 0x5XXXX0)

The full-scale register is a 24-bit register that holds the full-scale calibration coefficient for the ADC. The AD7192 has 4 full-scale registers so each channel has a dedicated full-scale register. The full-scale registers are read/write registers. However, when writing to the full-scale registers, the ADC must be placed in power-down mode or idle mode. These registers are configured on power-on with factory-calibrated full-scale calibration coefficients, the calibration being performed at gain = 1. Therefore, every device will have different default coefficients. The default value will be automatically overwritten if an internal or system full-scale calibration is initiated by the user or the full-scale register is written to.